

Notice of References Cited	Application/Control No. 10/523,107		Applicant(s)/Patent Under Reexamination INOUE ET AL.	
	Examiner MINH D. A		Art Unit 2821	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,087,757	07-2000	Honbo et al.	310/316.01
*	B	US-6,593,707	07-2003	Shih, Wen-Chu	315/277
*	C	US-6,661,181	12-2003	Shin, Chung-Hyuk	315/169.4
*	D	US-6,570,344	05-2003	Lin, Yung-Lin	315/224
*	E	US-6,087,757	07-2000	Honbo et al.	310/316.01
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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